

BILLING CODE 3510-DS-P

DEPARTMENT OF COMMERCE

International Trade Administration

University of California, Riverside, et al.

Notice of Consolidated Decision on Applications

for Duty-Free Entry of Electron Microscope

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials

Importation Act of 1966 (Pub. L. 89-651, as amended by Pub. L. 106-36; 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 A.M. and 5:00 P.M. in Room 3720, U.S. Department of Commerce, 14th and Constitution Avenue, NW, Washington, D.C.

Docket Number: 16-010. Applicant: University of California, Riverside, Riverside, CA 92521. Instrument: Electron Microscope. Manufacturer: FEI Company, the Netherlands. Intended Use: See notice at 81 FR 71702-03, October 18, 2016.

Docket Number: 16-018. Applicant: UChicago Argonne,
Lemont, IL 60439. Instrument: Electron Microscope.

Manufacturer: FEI Company, Czech Republic. Intended Use:

See notice at 81 FR 89433-34, December 12, 2016.

Docket Number: 16-022. Applicant: Regents of the
University of Colorado, Denver, CO 80203. Instrument:
Electron Microscope. Manufacturer: FEI Company, Brno
Czech Republic. Intended Use: See notice at 81 FR 8943334, December 12, 2016.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as this instrument is intended to be used, is being manufactured in the United States at the time the instrument was ordered. Reasons: Each foreign instrument is an electron microscope and is intended for research or scientific educational uses requiring an electron microscope. We know of no electron microscope, or any other instrument suited to these purposes, which was being manufactured in the United States at the time of order of each instrument.

Gregory W. Campbell Director Subsidies Enforcement Office Enforcement and Compliance

Dated: May 22, 2017

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